**P-Channel MOSFET** 

### **General Description**

The WSF12P04 is the highest performance trench P-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSF12P04 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Features**

- 100% UIS Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

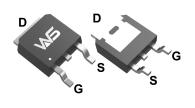
### **Product Summery**

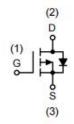
BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>
-40V	35mΩ	-12A

#### **Applications**

- Power Management for Industrial DC/DC Converters
- Ldeal for high-frequency switching and synchronous rectification

## **TO-252-2L Pin Configuration**





## **Absolute Maximum Ratings** (T<sub>A</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage		-40	-40 V	
V <sub>GS</sub>	Gate-Source Voltage		±20	V	
1 7	Continuous Drain Current	T <sub>C</sub> =25°C	-12		
I <sub>D</sub> <sup>7</sup>	Continuous Drain Current	T <sub>C</sub> =100°C	T <sub>C</sub> =100°C	-8	Α
I <sub>DM</sub> <sup>3</sup>	Pulse Drain Current		-50	W A	
P <sub>D</sub> <sup>2</sup>	Power Dissipation	T <sub>C</sub> =25°C	87	W	
I <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Current		-25	А	
E <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Energy	L=0.5mH	40	mJ	
T <sub>STG</sub>	Storage Temperature Range		-55 to 150	- °C	
TJ	Operating Junction Temperature Range		-55 to 150	C	
D 14	Thermal Decistance Junction to Ambient	t≤10s	31		
R <sub>θJA</sub> <sup>1,4</sup>	Thermal Resistance-Junction to Ambient	Steady State	62.5	°C/W	
R <sub>θJC</sub>	Thermal Resistance-Junction to Case		4		

**P-Channel MOSFET** 

### Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250μA	-40			V
		V <sub>GS</sub> =-10V , I <sub>D</sub> =-20A		35	40	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	T <sub>J</sub> =125°C		60		mΩ
		$V_{GS}$ =-4.5V , $I_D$ =-15A		48	65	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_{D}=-250\mu A$	-1.0	-1.5	-2.2	V
l	Duein Course Leakens Cumant	V <sub>DS</sub> =-40V , V <sub>GS</sub> =0V			-1.0	
I <sub>DSS</sub>	Drain-Source Leakage Current	T <sub>J</sub> =55°C			-5.0	5.0 µA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{DS}$ =0V , $V_{GS}$ =±20V			±100	nA
9 <sub>fs</sub>	Forward Transconductance	$V_{DS}$ =-5V , $I_{D}$ =-18A		13		S
$R_G$	Gate Resistance	f=1.0MHz		14		Ω
$Q_g$	Total Gate Charge (10V)			10		
$Q_{gs}$	Gate-Source Charge	$V_{DS}$ =-40V , $V_{GS}$ =-10V , $I_{D}$ =-20A		3		nC
$Q_{gd}$	Gate-Drain Charge			3.5		
T <sub>d(on)</sub>	Turn-On Delay Time			20		
T <sub>r</sub>	Rise Time	$V_{DD}$ =-40V , $V_{GS}$ =-10V , $I_{D}$ =-20A		13		no
$T_{d(off)}$	Turn-Off Delay Time	$R_{I}=1\Omega$ , $R_{GEN}=3\Omega$		50		ns
T <sub>f</sub>	Fall Time			5		
C <sub>iss</sub>	Input Capacitance			1000		
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =-25V , $V_{GS}$ =0V , $f$ =1.0MHz		110		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			85		

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I <sub>S</sub> <sup>7</sup>	Continuous Source Current				-23	Α
$V_{SD}$	Diode Forward Voltage V <sub>GS</sub> =0V , I <sub>S</sub> =-1A				-1.1	V
t <sub>rr</sub>	Reverse Recovery Time	l <sub>F</sub> =-20A , di/dt=500A/μs		31		ns
Q <sub>rr</sub>	Reverse Recovery Charge	1 <sub>F</sub> 20A , α//αι-300A/μs		10		nC

#### Note:

- 1. The value of R<sub>BJA</sub> is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>BJA</sub> t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 2. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.
- 4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu s$  pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.
- 9. The maximum current rating is silicon limited



## **Typical Characteristics**

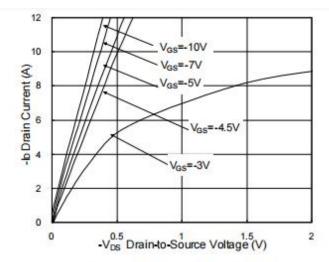


Fig.1 Typical Output Characteristics

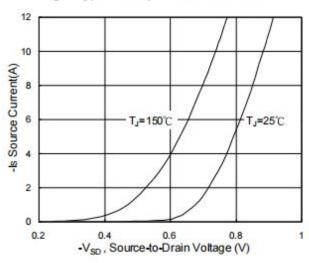


Fig.3 Forward Characteristics of Reverse

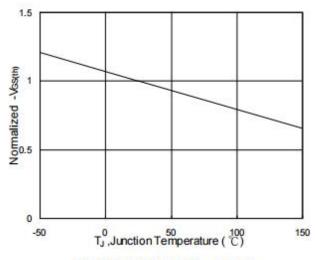


Fig.5 Normalized V<sub>GS(th)</sub> v.s T<sub>J</sub>

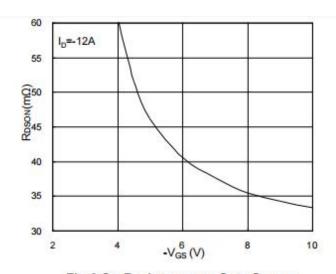


Fig.2 On-Resistance v.s Gate-Source

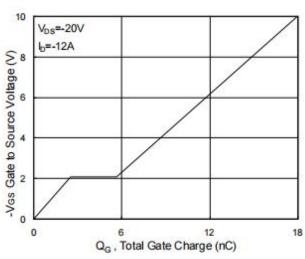


Fig.4 Gate-Charge Characteristics

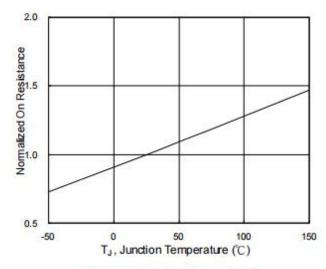
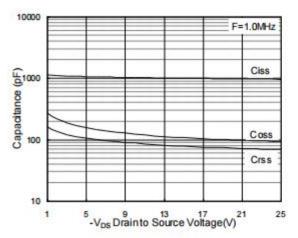


Fig.6 Normalized Roson v.s TJ





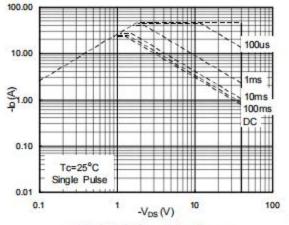


Fig.7 Capacitance

Fig.8 Safe Operating Area

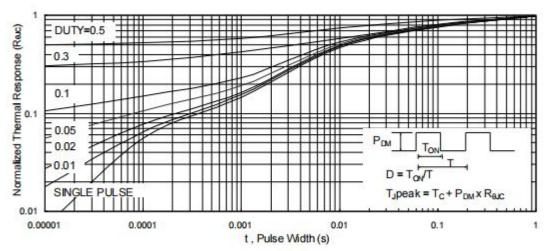
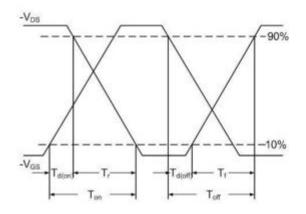


Fig. 9 Normalized Maximum Transient Thermal Impedance



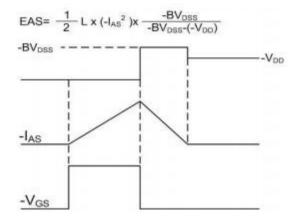
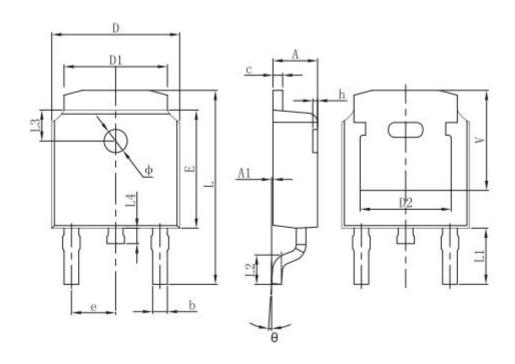


Fig.10 Switching Time Waveform

Fig.11 Unclamped Inductive Waveform



# **Packaging information**



Combal	Dimensions	In Millimeters	Dimension	s In Inches	
Symbol	Min.	Max.	Min.	Max.	
Α	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.635	0.770	0.025	0.030	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.830	REF.	0.190	REF.	
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.712	10.312	0.382	0.406	
L1	2.900	REF.	0.114	REF.	
L2	1.400	1.700	0.055	0.067	
L3	1.600 REF.		0.063 REF.		
L4	0.600	1.000	0.024	0.039	
Ф	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.250	REF.	0.207	REF.	





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